

METHOD OF CALCULATING WRITE CONDITION DETECTION INDEX AND OPTICAL DISK WRITING METHOD AND APPARATUS USING THE METHOD

BACKGROUND OF THE INVENTION

Field of the Invention

The present invention relates to a method of calculating a write condition detection index, the method determining an index used for detection of a write condition for an optical disk when information is written to the optical disk, as well as an optical disk writing method and apparatus using the above method.

Description of the Related Art

Parameters indicating a write condition for an optical disk include an "asymmetry value", indicating the degree of asymmetry of a RF (Radio Frequency) waveform obtained by reading a written waveform, and a " β value (β)".

If a data signal is to be written to an optical disk such as a CD-R, it is modulated using an EFM (Eight to Fourteen Modulation) method. With this method, nine time intervals that are each three to eleven times (other values may be used depending on the type of the disk) as long as a predetermined reference time interval T are provided as high- and low-level time intervals for a reference digital signal. FIGS. 8A, 8B and 8C show waveforms read from a disk to which information has been written in the above manner. FIG. 8A indicates that the amplitude has a large value when lands are long and that

the amplitude is low when the lands have a length of 3T. Further, as shown in FIG. 8A, if the ground of a non-DC-cut (DC-coupled) HF signal is defined as a 0 level position, and the land and pit levels at 3T and the land and pit levels at 11T are defined as I3L and I3P, and I11L and I11P, respectively, then the asymmetry is expressed by the following equation.

$$\text{Asymmetry value} = \{(I3L + I3P)/2 - (I11L + I11P)/2\} / (I11L - I11P) \quad \dots (6)$$

As shown in FIGS. 8A, 8B and 8C, the asymmetry value decreases with increasing write power, while increasing with decreasing write power.

The β value is the index that indicates the degree of asymmetry of a waveform written to an optical disk. For the RF waveform shown in FIG. 8C and obtained by reading the written waveform, if the AC-ground of a DC-cut (AC-coupled) HF signal is defined as a 0 level and the land- and pit-side levels of the HF signal envelope are defined as A1 and A2, then the β is expressed by the following equation:

$$\beta \text{ value} = (A1 + A2) / (A1 - A2) \quad \dots (7)$$

As shown in FIGS. 8A, 8B and 8C, in contrast to the asymmetry value, the β value increases consistently with write power, while decreasing consistently with write power.

The β value (or asymmetry value. These will be interchangeably used below) and jitters have the relationship shown in FIG. 9. If the β value is excessively large or small, jitters are likely to become worse. The range of the β value corresponding to tolerable jitter values is generally called

a "power margin". The power margin varies depending on the type of the optical disk. In particular, optical disks with narrow power margins have their β value vary significantly, and thus need to have such a write condition that the β value is stable and uniform all over the surface of the optical disk. In recent years, a high-double-speed write technique has been popularized, and such a technique tends to involve a much narrower power margin. Thus, it has recently been more desirable to establish such a write condition that the β value is stable and uniform all over the surface of the optical disk.

Under these circumstances, a normal method of writing information to an optical disk comprises calibrating optimum write power (this operation will hereinafter be referred to as "OPC") in a predetermined power calibration area (this will hereinafter be referred to as a "PCA") and then actually writing information to a data write area with the fixed optimum write power determined by OPC.

However, due to the causes listed below, the write condition for the optical disk may not be optimum in spite of the optimum power determined by the OPC.

1) Variation in the characteristics of the optical disk depending on a position within the surface of the disk.

2) Variation in the offset between the optical axis of a laser beam from an optical head and the mechanical inclination of the write surface of the optical disk, depending on a position in the surface of the disk. This is due to a variation in radial skew within the surface, the warp of the disk, or the

like. The term "radial skew" refers to the angle between the optical axis of the optical pickup in its radial direction and the normal of the optical disk.

3) Variation in the characteristics of the optical disk
5 caused by a variation in temperature between OPC and actual writes.

4) Variation in write characteristics caused by a
variation in the wavelength of a semiconductor laser element
associated with a variation in temperature between OPC and
10 actual writes.

To solve these problems, an operation may be performed
which comprises detecting the write condition during a write
using various methods, correcting the write power on the basis
of the detected conditions, and maintaining the write condition
15 established during the OPC (this operation is generally
referred to as "running OPC").

For example, the techniques disclosed in Japanese Patent
Application Laid-Open No. 2000-215454 (hereinafter referred
to as a "first conventional example"), Japanese Patent
20 Application Laid-Open No. 9-270128 (hereinafter referred to
as a "second conventional example"), and Japanese Patent
Application Laid-Open No. 9-91705 (hereinafter referred to
as a "third conventional example") are known as running OPC.

In the first conventional example, on the basis of the
25 peak value of the level of write pit reflected light (this
will hereinafter be referred to as a "peak value") and the
sampling hold level of the latter half of the write pit reflected

light (this will hereinafter be referred to as a "B value"), the write condition is detected using the following equation, to correct the write power:

$$\begin{aligned} & \text{Write condition detection index} = (\text{B value}) / (\text{peak value}) \\ 5 \quad & \dots (11) \end{aligned}$$

That is, during OPC, the write condition detection index is measured on the basis of the above equation and used as a write condition detection index target value. Further, the write power is controlled so that the write condition detection index measured during a write to a data write area equals the target value.

In the second conventional example, on the basis of the peak value and the B value, the write condition is detected using the following equation, to correct the write power:

$$\begin{aligned} 15 \quad & \text{Write condition detection index} = (\text{peak value}) / N - (\text{B value}) \\ & \dots (12) \end{aligned}$$

where N is an experimental value determined for each type of optical disk.

In the third conventional example, the peak value is not used as an operational parameter in contrast to the first and second conventional examples. That is, on the basis of the level of write pit reflected light and the write power, the write condition is detected using the following equation, to correct the write power:

$$\begin{aligned} 25 \quad & \text{Write condition detection index} = (\text{write pit reflected light level}) / (\text{write power}) \\ & \dots (13) \end{aligned}$$

That is, the write condition detection index is measured at the start of a write to a data write area on the basis of the above equation and used as a write condition detection index target value. Further, the write power is controlled so that the write condition detection indices measured during subsequent writes to data write areas equal the target value.

However, the first to third conventional examples have the following problems:

In the first and second conventional examples, the peak value included in both Equations (11) and (12) is drastically affected by the frequency characteristics of a reflected light detecting circuit, and the frequency characteristics vary even with temperature. Thus, it is difficult to stably measure the peak value. Further, a peak hold circuit is required to obtain a peak value, thereby increasing circuit costs.

Furthermore, due to various factors, a variation in write condition cannot be properly followed by using the method of controlling the write power on the basis of the write condition detection index obtained using Equations (11) and (12).

Furthermore, for certain types of optical disks, the write condition detection index cannot be properly detected.

In the second conventional example, the value N included in Equation (12) is given for each type of optical disk, so that this method cannot deal with many types of optical disks easily. Furthermore, different optical write devices have different N s, so that this example is not suited for mass production.

In the third conventional example, the write condition detection index determined using Equation (13) exhibits a small variation with respect to the write power for some types of optical disks and thus has low detection sensitivity.

5 Accordingly, it is difficult to increase the accuracy of running OPC. Further, due to various factors, a variation in write condition cannot be properly followed by using the method of controlling the write power on the basis of the write condition detection index obtained using Equation (13).

10 FIG. 10 is a graph showing the results of running OPC according to the third conventional example. If information is written to the entire surface of the optical disk with the write power fixed, that is, without running OPC, the β value is about 10% smaller at the outer circumference of the disk
15 than at the inner circumference thereof. If running OPC is executed on this optical disk to write information to the entire surface, the β value is about 5% larger at the outer circumference of the disk than at the inner circumference thereof. The results of the experiments indicate that running
20 OPC improved the variation in β value from -10% only to +5%. However, the ideal variation is 0%.

SUMMARY OF THE INVENTION

It is thus an object of the present invention to provide a method of calculating a write condition detection index with
25 improved stability for a variation in temperature or the like and with improved detection sensitivity for the write condition,

as well as an optical disk writing method and apparatus using the above method.

A method of calculating a write condition detection index according to the present invention determines an index R_m that is indicative of a write condition for an optical disk when information is written to the optical disk. That is, a stable-intensity portion of light reflected when the disk is irradiated with laser beams with power P_{w1} that is sufficient to generate pit portions is detected as a light intensity level S_p , the intensity of light reflected from a space portion when the disk is irradiated with laser beams with power that is insufficient to generate pit portions is detected as a light intensity level S_s , and the index R_m is determined using the equation $R_m = S_p/S_s/(P_{w1})^2 \dots (1)$. Alternatively, a stable-intensity portion of light reflected when the disk is irradiated with laser beams with power P_{w1} that is sufficient to generate pit portions is detected as a light intensity level S_p , and the index R_m is determined using the equation $R_m = S_p/(P_{w1})^2 \dots (2)$.

The peak value of the intensity of light reflected when the disk is irradiated with laser beams with the power P_{w1} is not used, thereby providing a stable write condition detection index that is not affected by a variation in temperature or the like. Further, the use of the power $(P_{w1})^2$ increases a variation with respect to the write power, thereby providing a write condition detection index with improved detection sensitivity for the write condition.

In this case, the index R_m is determined for at least one circumference of the optical disk, and these indices R_m are averaged to obtain a true index R_m . Alternatively, for each of the S_p , S_s , and P_w1 , the measured values are averaged, and using the average values obtained, the index R_m is calculated. In these cases, the write condition detection index is more accurate.

An optical disk writing method according to the present invention comprises using the method of calculating a write condition detection index according to the present invention to measure the index R_m whenever information is written to the optical disk and controlling the power P_w1 so as to minimize a difference between the index R_m and a target value thereof.

In this case, the target value may be the index R_m measured during OPC, measured when calibration is executed in the PCA with optimum write power, or measured immediately after the start of a write to a data write area, using the method of calculating a write condition detection index according to the present invention.

An optical disk write apparatus according to the present invention determines an index R_m that is indicative of a write condition for an optical disk in writing information to the optical disk and controls power P_w1 that is sufficient to generate pit portions so as to minimize a difference between the index R_m and a target value thereof. That is, this apparatus comprises means for detecting, as a light intensity level S_p , a stable-intensity portion of light reflected when

the disk is irradiated with laser beams with the power $Pw1$, means for detecting, as a light intensity level Ss , the intensity of light reflected from a space portion when the disk is irradiated with laser beams with power that is

5 insufficient to generate pit portions, means for determining the index Rm using the equation $Rm = Sp/Ss/(Pw1)^2 \dots (1)$, and means for controlling the power $Pw1$ so as to minimize a difference between the index Rm and the target value thereof.

Alternatively, the apparatus comprises means for detecting,
10 as a light intensity level Sp , a stable-intensity portion of light reflected when the disk is irradiated with laser beams with the power $Pw1$, means for determining the index Rm using the equation $Rm = Sp/(Pw1)^2 \dots (2)$, and means for controlling the power $Pw1$ so as to minimize a difference between the index
15 Rm and the target value thereof.

BRIEF DESCRIPTION OF THE DRAWINGS

The novel features believed characteristic of the invention are set forth in the appended claims. The invention itself, however, as well as other features and advantages
20 thereof, will be best understood by reference to the detailed description which follows, read in conjunction with the accompanying drawings, wherein:

FIG. 1A to 1E are a view useful in describing an embodiment of a method of calculating a write condition detection index
25 according to the present invention;

FIG. 2 is a graph showing the results of running OPC according to the present invention;

FIG. 3 is a block diagram showing an embodiment of an optical disk write apparatus according to the present invention;

FIG. 4 is a flow chart showing an example of the operation of the optical disk write apparatus in FIG. 3;

FIG. 5 is a flow chart showing an example of the operation of the optical disk write apparatus in FIG. 3;

FIG. 6 is a flow chart showing an example of the operation of the optical disk write apparatus in FIG. 3;

FIG. 7 is a flow chart showing an example of the operation of the optical disk write apparatus in FIG. 3;

FIGS. 8A to 8C are graphs useful in describing an asymmetry value and a β value, wherein FIG. 8A is a graph with high write power, FIG. 8B is a graph with intermediate write power, and FIG. 8C is a graph with low write power;

FIG. 9 is a graph showing an example of the relationship between the β value and jitters; and

FIG. 10 is a graph showing the results of running OPC according to a third conventional example.

DESCRIPTION OF THE PREFERRED EMBODIMENTS

FIG. 1 is a view useful in describing an embodiment of a method of calculating a write condition detection index according to the present invention. With reference to this drawing, the embodiment will be described below.

First, two levels are detected: a level obtained by sampling and holding the latter half of light reflected from an optical disk when information is written to the disk with write power that is sufficient to generate pits (this will hereinafter be referred to as a "write pit reflected light level S_p "), and a level obtained by sampling and holding light reflected from a space portion of the optical disk when information is written to the disk with read power that is insufficient to generate pits (this will hereinafter be referred to as a "write space reflected light level S_s "). Then, an index that is indicative of the write condition for the optical disk is determined from these detected values S_p and S_s and write power P_{w1} with which a laser beam from a semiconductor laser element exits an objective of an optical head during a write, using the following equation:

$$(\text{write condition detection index } R_m) = (\text{write pit reflected light level } S_p) / (\text{write space reflected light level } S_s) / (\text{write power } P_{w1})^2 \quad \dots (1)$$

The write power is controlled on the basis of the write condition detection index R_m .

Alternatively, to simplify the circuit, the write condition detection index R_m can be determined using the following equation, which does not use the write space reflected light level S_s :

$$(\text{write condition detection index } R_m) = (\text{write pit reflected light level } S_p) / (\text{write power } P_{w1})^2 \quad \dots (2)$$

Before an actual write to a data write area, an operation (OPC) of calibrating optimum write power $Pw0$ is performed in a predetermined PCA in the optical disk. Further, during a write with optimum power $Pw0$, the write condition detection index Rm is measured using Equation (1) or (2). This write condition detection index is stored as a write condition detection index target value Rt , and the write power $Pw1$ is controlled so as to minimize a write condition detection index error ΔRm , that is, a difference between the write condition detection index Rm measured during a subsequent actual write to the data area and its target value Rt . An operation of thus controlling the write power while detecting the write condition is referred to as "running OPC".

Without running OPC, information is written to the data area with the fixed optimum write power already determined by OPC, so that this optimum write power is not always optimum due to various factors. As a result, the write condition may vary to degrade write quality. A "variation in write condition" as used herein refers to a variation in the asymmetry of a waveform obtained by reading a written waveform. The asymmetry is represented as an asymmetry value or a β value as described previously.

In this embodiment, if information is written using a running OPC control method, this operation can be performed while maintaining a stable write condition (that is, a stable asymmetry or β value) with the optimum write power $Pw0$ determined by OPC as shown in FIG. 2. Thus, stable write

quality (that is, a uniform asymmetry or β value) can be realized all over the surface of the optical disk.

FIG. 3 is a block diagram showing an embodiment of an optical disk write apparatus according to the present invention.

5 With reference to this drawing, the optical disk write apparatus will be described below. At the same time, an optical disk writing method will be described.

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10 An optical disk 1 is installed on a turntable 22 rotated by a spindle motor 2, and an optical head 3 reads and writes data from and to the optical disk 1. Laser beams output from a semiconductor laser element 4 in the optical head 3 are reflected by a half mirror 23 and then pass through an objective 5 to focus on the optical disk 1. Laser beam reflected light from the optical disk 1 returns to the optical head 3 and has
15 its quantity of light detected by a signal-detecting photo detector 8 that is divided into a plurality of pieces. The light is then converted into voltage signals by a current-voltage converting amplifier 14, and these voltage signals are supplied to the respective blocks. Of the
20 plurality of voltage signals, a sum signal for a main beam is used as a RF signal 21 to read out a written waveform from the optical disk 1 or detect the write condition during a write.

Further, a matrix of the plurality of voltage signals obtained by the current-voltage converting amplifier 14
25 becomes a servo controlling detection signal 25. The servo controlling detection signal 25 controls a focus mechanism that focuses laser beams on the optical disk 1 and a tracking

mechanism that causes a laser beam spot to follow a track on the optical disk 1.

When data is written to the optical disk 1, the disk is irradiated with laser beams alternately with write power and read power (FIG. 1B) in order to generate pits on the optical disk 1. To achieve this, only the voltage signals resulting from light reflected upon irradiation with the read power are held as servo control signals by a sample hold circuit 15. The servo control signals are processed by a servo control circuit 16 to drive a tracking/focus mechanism 6 of the optical head 3 to control the objective 5, thereby servo-controlling the laser beam spot to a predetermined position on the optical disk 1. Further, although not shown, a thread mechanism is provided which moves the optical head 3 toward the inner or outer circumference of the optical disk. The thread mechanism allows the laser beam spot to roughly follow the track.

On the other hand, a front monitor light-receiving element 7 is irradiated directly with some of the laser beams output from the semiconductor laser element 4 which are transmitted through the half mirror 23. Thus, the intensity of laser beams from the semiconductor laser element 4 is converted into a voltage signal (front monitor detection signal 24) by a current-voltage converting amplifier 9. The front monitor detection signal 24 is used for auto power control (hereinafter referred to as "APC") that maintains the laser beam intensity at a set value.

During a write to the optical disk, laser beams are emitted alternately with the write power and the read power in order to generate pits on the optical disk 1. Thus, front monitor detection signals 24 obtained at the moment when the disk is irradiated with laser beams with the read power or the write power are held by sample hold circuits 10 and 11 and input to a read APC circuit 12 and a write APC circuit 13, respectively. The APC circuits 12 and 13 have their emitted power target values set by a write power/read power control section 20 to control APC on the basis of each sample and hold signal from the front monitor detection signal 24 so that the laser beam intensity equals this set power.

Then, during a read, the reflected light voltage signal 21 from the optical disk 1 is input to an asymmetry detecting circuit 17. As a result, an asymmetry or β value, which is indicative of the asymmetry of a read waveform, is detected.

The reflected light voltage signal 21 from the optical disk 1 is also input to a pit reflected light sample hold circuit 18, and has a waveform such as the one shown in FIG. 1C during a write. The pit reflected light sample hold circuit 18 samples and holds, as a write pit reflected light signal 26, the latter half of the reflected light voltage signal 21 obtained when the disk is irradiated with the write power; this portion has a stable reflected light level due to saturated pit generation.

Likewise, the reflected light voltage signal 21 is input to a space reflected light sample hold circuit 19, and has a waveform such as the one shown in FIG. 1C during a write.

The space reflected light sample hold circuit 19 samples and holds, as a write space reflected light signal 27, a stable-reflected-light-level portion of the reflected light voltage signal 21 obtained when the disk is irradiated with the read power.

The write pit reflected light signal 26 and the write space reflected light signal 27 are input to a write condition detection index calculating section 20. The write condition detection index calculating section 20 determines the "write condition detection index". On the basis of this write condition detection index, the write power is controlled and running OPC is executed.

FIGS. 4 to 7 are flow charts showing examples of the operation of the optical disk write apparatus of this embodiment. These examples will be described with reference to FIGS. 1 to 7.

First, as shown in FIG. 4, before an actual write to a data area, an operation (OPC) of calibrating the optimum write power $Pw0$ is performed in a predetermined PCA of the optical disk 1.

That is, the write power control section 20 writes data while varying the write power step by step (step 100). The resulting waveform is read out, and the asymmetry detecting circuit 17 measures the asymmetry (or β) corresponding to each write power. This provides a graph of a curve representative of write power vs. asymmetry (or β). By linearly approximating the measured values on the curve, the write power $Pw0$

corresponding to a target asymmetry (or target β) predetermined for each disk 1 is mathematically determined as optimum write power. The write power $Pw1$ is set as this optimum write power $Pw0$ (step 102). Simultaneously with this write operation,
5 the pit reflected light sample hold circuit 18 and the space reflected light sample hold circuit 19 measure and store the write pit reflected light level Sp and write space reflected light level Ss (step 101).

An example of a manner of determining a target asymmetry
10 (or target β) will be described below. Upon initializing the disk (medium), the optical disk apparatus reads data already written to the disk and called "special information" to identify a disk ID in the data, and executes a write using one of the strategies listed in a strategy table, described
15 later, which corresponds to the disk ID and write speed and using the target asymmetry (β) corresponding to that strategy. As a target asymmetry, an asymmetry value is selected such that the range of power, that is, a power margin (see FIG. 9) is maximized for each strategy value when tolerable jitters
20 are generated. The term "strategy" refers to time for which the disk is irradiated with laser beams with write power precisely set so as to most clearly write data to the disk. The strategy depends on the type of the disk and the write speed and thus exists for each disk type and each write speed.
25 The strategies are provided in the OPC control section 20 as a strategy table. The manner of determining a target asymmetry is not limited to the above example, but may be another.

Timings for these detection signals are as shown in FIG.

1. During a write, the RF signal 21 has a waveform such as the one shown in FIG. 1C and has a low waveform level at the start of irradiation with the pit generation write power. Then, as pits are gradually formed, the quantity of reflected light gradually decreases. After a specified time, when the pit generation starts to be saturated, the signal level is also saturated and stabilized. The stable level of light reflected during the latter half of irradiation with the pit generation write power is sampled and held by the pit reflected light sample hold circuit 18 using the timing shown in FIG. 1D. This is set as a write pit reflected light level Sp. The waveform shown in FIG. 1B and obtained when data is written to the disk with the read power is sampled and held by the space reflected light sample hold circuit 19 as a write space reflected light level Ss.

On the basis of the detected values Sp and Ss measured in the above manner, the write condition detection index calculating section 20 uses Equation (1) or (2), shown below, to determine the write condition detection index Rm corresponding to the optimum write power Pw0 determined by OPC (step 103). This is stored as a write condition detection index target value Rt (step 104).

$$\begin{aligned} &(\text{write condition detection index } R_m) = (\text{write pit} \\ &\text{reflected light level } S_p) / (\text{write space reflected light level} \\ &S_s) / (\text{write power } P_{w1})^2 \quad \dots (1) \end{aligned}$$

(write condition detection index R_m) = (write pit
reflected light level S_p) / (write power P_{w1})² ... (2)

With Equation (2), the write space reflected light level
 S_s is not used as an operational parameter, thereby eliminating
5 the need for the space reflected light sample hold circuit
19. Thus, advantageously, circuit costs can be reduced, and
loads on a detection circuit and an arithmetic circuit can
be reduced during writes. However, disadvantageously, if the
reflection factor of the optical disk 1 varies, an error may
10 occur in the maintenance and control of the write condition.

Also in this case, the method of determining the write
condition detection index R_m using Equation (1) serves to
achieve better write characteristics. Equation (1) is
effective if the reflection factor of the optical disk 1 varies.
15 For example, it is more effective on optical disks having a
reflection factor that varies with temperature.

FIG. 5 shows an alternative method of determining a write
condition detection index target value R_t .

First, the optimum write power P_{w0} is determined by OPC
20 (step 110). This step is the same as steps 100 to 102 in FIG.
4. The write power P_{w1} is set at this optimum write power
 P_{w0} (step 111), and data is written to several frames of the
PCA with the optimum write power ($P_{w1} = P_{w0}$) (step 112).
Simultaneously with this write operation, the pit reflected
25 light sample hold circuit 18 and the space reflected light
sample hold circuit 19 measure the write pit reflected light
level S_p and the write space reflected light level S_s (step

113), determine the write condition detection index R_m from the detected values using Equation (1) (or (2)) (step 114), and store it as a target value R_t (step 115).

FIG. 6 shows an alternative method of determining a target value R_t .

The optimum write power is determined by OPC (step 120), the write power P_{w1} is set at this optimum write power P_{w0} (step 121), and an actual write to the data write area is started with this write power ($P_{w1} = P_{w0}$) (step 122). Subsequently, the pit reflected light sample hold circuit 18 and the space reflected light sample hold circuit 19 measure the write pit reflected light level S_p and the write space reflected light level S_s (step 123), determine the write condition detection index R_m from the detected values using Equation (1) (or (2)) (step 124), and store it as a target value R_t (step 125).

A target value R_t is determined in accordance with any of the flow charts of FIGS. 4 to 6, described previously. During a subsequent actual write to the data write area, the write power control (running OPC) shown in FIG. 7 is executed.

First, data is written to the data write area with the already set write power P_{w1} (step 131). Then, the pit reflected light sample hold circuit 18 and the space reflected light sample hold circuit 19 sample and hold the waveform in FIG. 1B, and measure the write pit reflected light level S_p and the write space reflected light level S_s (step 132). At this time, measurement is carried out for at least one rotation of the disk in order to accommodate a variation in detected

value associated with the rotation cycle of the optical disk,
and the detected values are then averaged.

Subsequently, the write condition detection index
calculating section 20 determines the write condition

5 detection index R_m using Equation (1) (or (2)) (step 133).

In FIG. 7, measurement is carried out for at least one rotation
to obtain averaged S_p and S_s to determine the index R_m on the

basis of the S_p and S_s , but the index R_m may be found for each
of the measured S_p and S_s values so that these indices R_m can

10 be averaged to obtain a write condition detection index R_m .

Then, a difference between the write condition detection index
 R_m and its target value R_t , that is, a "write condition detection
error ΔR_m ", is determined using the following equation (step
134):

15
$$(\text{write condition detection error } \Delta R_m) = (\text{write condition} \\ \text{detection index } R_m) - (\text{target value } R_t) \quad \dots (3)$$

Subsequently, one of the following processes A to C is
executed.

A. The write condition detection error ΔR_m is compared
20 with a write power control threshold H_s (step 135). If the
error ΔR_m is equal to or larger than the threshold H_s , then
it can be determined that the "write power is too low to maintain
the write condition", so that the write power P_w is increased
by a write power step width ΔP_w on the basis of the following
25 equation (step 136).

$$(\text{write power } P_w) \leftarrow (\text{write power } P_w) + (\text{write power} \\ \text{step width } \Delta P_w) \quad \dots (4)$$

B. The write condition detection error ΔR_m is compared with a write power control threshold $-H_s$ (step 137). If the error ΔR_m is equal to or smaller than the threshold $-H_s$, then it can be determined that the "write power is too high to maintain the write condition", so that the write power P_{w1} is reduced by a write power step width ΔP_w on the basis of the following equation (step 138).

$$(\text{write power } P_{w1}) \leftarrow (\text{write power } P_{w1}) - (\text{write power step width } \Delta P_w) \quad \dots (5)$$

C. If the conditions do not correspond to the case A or B, that is, $-H_s < \Delta R_m < +H_s$, then the write power P_{w1} is not varied.

The operation shown in FIG. 7 is repeated as long as a data write is continued (step 139).

The present invention is not limited to the above embodiment. For example, rather than using the pit reflected light sample hold circuit 18 and the space reflected light sample hold circuit 19, write reflected light may be AD-converted to mathematically determine the quantity of write pit or space reflected light.

Further, Equation 1 or 2 is used to calculate the write condition detection index, and in both equations, the numerator is (write power)². Here, the write power may be an alternative that is substantially the same as the write power, that is, a signal corresponding to the write power. For example, if subbeams are used as in the case with an operation push pull method, the quantity of reflected light resulting from front

subbeams can be substituted with the write power.

Alternatively, the write power may be substituted with a front monitor signal level.

According to the method of calculating a write condition
5 detection index according to the present invention, by using
the square of the power $Pw1$ that is sufficient to generate
pit portions, the light intensity level Sp of a
stable-intensity portion of light reflected when the disk is
irradiated with laser beams with the power $Pw1$, and the light
10 intensity level Ss of light reflected from a space portion
when the disk is irradiated with laser beams with power that
is insufficient to generate pit portions, the index Rm is
determined on the basis of the equation $Rm = Sp/Ss/(Pw1)^2$ or
 $Rm = Sp/(Pw1)^2$, thereby producing the following effects: The
15 present invention does not use the peak value of the intensity
of light reflected when the disk is irradiated with laser beams
with the power $Pw1$, thereby ensuring a stable write condition
detection index, which is not affected by a variation in
temperature or the like. Further, the use of the square of
20 the power $Pw1$ serves to increase a variation with respect to
the write power, thereby providing a write condition detection
index with improved detection sensitivity for the write
condition.

According to the optical disk writing method and apparatus
25 according to the present invention, a write condition detection
index with improved stability for a variation in temperature
and with improved detection sensitivity for the write condition

is obtained using the method of calculating a write condition detection index according to the present invention. This index can more appropriately follow a variation in write condition. In other words, the write condition detection index is measured under the optimum write condition as the target value R_t , and the write condition detection index R_m is constantly measured during actual writes to the data area. Then, the write power P_w is controlled so as to minimize a difference between the index R_m and the target value R_t , thereby maintaining a stable optimum write condition. That is, always stable and uniform write quality, that is, an optimum β value (asymmetry value), is maintained all over the surface of the optical disk.

The graph in FIG. 2 shows the results of experiments carried out to check the effects of the present invention. In these experiments, to check the effects of the present invention by enabling and disabling the functions according to the present invention using the same environment, data was written to the entire optical disk while alternately enabling and disabling the functions according to the present invention. In this case, when data was written to the entire surface of the optical disk with the write power fixed, that is, without running OPC, then the β value is about 9% smaller at the outer circumference of the disk than at the inner circumference thereof due to a difference in sensitivity within the surface of the optical disk. In contrast, with running OPC according

to the present invention, the variation in β value between the inner and outer circumferences is within about $\pm 1\%$.

Further, the present invention does not use the "peak value of write pit reflected light", which has made

5 measurements with conventional running OPC difficult, thereby avoiding errors in write condition detection index caused by errors in measurement of the peak value of write pit reflected light.

Another problem of the prior art is that with some types
10 of optical disks, as the write power increases, a variation in write condition detection index gradually decreases to saturate the index. In contrast, since the numerator of the equation for the write condition detection index according to the present invention is the "square of the write power",
15 the write power with which the write condition detection index is saturated can be increased to widen the control range compared to the prior art, in which the numerator is the "first power of the write power".

Furthermore, compared to the prior art, in which the
20 numerator of the write condition detection index is the "first power of the write power", the numerator according to the present invention is the "square of the write power", so that the results of the experiments indicate that the write condition detection index according to the present invention
25 can more appropriately follow a variation in write condition as shown in the graph in FIG. 2.

Therefore, according to the present invention, running OPC with good and stable characteristics can be easily realized compared to the conventional running OPC method.

While this invention has been described with reference
5 to illustrative embodiments, this description is not intended
to be construed in a limiting sense. Various modifications
of the illustrative embodiments as well as other embodiments
of the invention, will be apparent to persons skilled in the
art upon reference to this description. It is, therefore,
10 contemplated that the appended claims will cover any such
modifications or embodiments as fall within the true scope
of the invention.

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